

Route to High Hole Mobility in GaN via Reversal of Crystal-Field Splitting

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A fundamental obstacle toward the realization of GaN *p*-channel transistors is its low hole mobility. Here we investigate the intrinsic phonon-limited mobility of electrons and holes in wurtzite GaN using the *ab initio* Boltzmann transport formalism, including all electron-phonon scattering processes and many-body quasiparticle band structures. We predict that the hole mobility can be increased by reversing the sign of the crystal-field splitting in such a way as to lift the split-off hole states above the light and heavy holes. We find that a 2% biaxial tensile strain can increase the hole mobility by 230%, up to a theoretical Hall mobility of 120 cm²/V s at room temperature and 620 cm²/V s at 100 K.

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Nitride semiconductors have played a central role in the development of energy-efficient light-emitting devices (LEDs) [1]. In particular, the realization of high-quality wurtzite GaN [2] enabled the successful commercialization of blue LEDs, Blu-ray optical disks, and white LED light bulbs. Besides its applications in photonics, GaN has been attracting considerable interest as one of the most promising semiconductors for power electronics [3,4], wireless communications [5], thermoelectric energy conversion [6], and radiation detection [7]. Recent advances have achieved epitaxial GaN/NbN semiconductor-superconductor heterostructures [8] with the potential for quantum technologies in this material system. Owing to its superior electric breakdown field due to its large band gap, and its high thermal conductivity due to the light N atoms, GaN based materials have potential in high voltage transistor applications for power electronics [4]. The two key obstacles toward this goal are the difficulty in achieving efficient *p*-type doping and the low mobility of hole carriers [4]. While the *p*-type doping challenge can now be addressed via polarization-induced doping [9] and *p*-type field-effect transistors have successfully been realized by this technique [10], there is no solution in sight for improving hole mobilities, which do not exceed 40 cm²/V s at room temperature [11–17]. In comparison, electron mobilities as high as 1265 cm²/V s at room temperature have been reported in bulk GaN and > 2000 cm²/V s in 2D electron gases [18]. Finding a practical strategy to increase the hole mobility of GaN would have wide-ranging implications in wireless communications as well as quantum technologies [8].

In this work we clarify the atomic-scale mechanisms that are responsible for the low hole mobilities in GaN, and we propose a practical strategy for overcoming the mobility bottleneck. We calculate mobilities using the state-of-the-

art *ab initio* Boltzmann transport formalism, including all electron-phonon scattering processes and quasiparticle *GW* band structures. The room temperature *electron* mobility in GaN is known to be limited by scattering from acoustic and polar optical phonons. In contrast, we show that the origin of the low *hole* mobility lies in the scattering of carriers in the light-hole (*lh*) and heavy-hole (*hh*) bands predominantly by long-wavelength longitudinal-acoustic phonons. The heavy masses of these bands and the associated density of final states conspire to reduce the mobility by nearly 2 orders of magnitude compared to electron carriers. Using this understanding, our calculations predict that the hole mobility can significantly be enhanced if the split-off hole band (*sh*) can be raised above the *lh* and *hh* bands. We show that this modification of the band structure can be achieved by reversing the sign of the crystal-field splitting via biaxial tensile strain, or equivalently via uniaxial compressive strain. We also show that the reversal of crystal-field splitting can be achieved dynamically by coherently exciting the *A*₁ optical phonon via ultrafast infrared optical pulses.

The key advance that has made our present investigation possible is the recent combination of the *ab initio* self-consistent Boltzmann transport equation with electron-phonon Wannier interpolation and *GW* quasiparticle band structures [19]. This new development enables parameter-free calculations of phonon-limited mobilities in semiconductors with an unprecedented predictive power. In this method the carrier mobilities are computed using the linearized Boltzmann transport equation (BTE) [19–21], which for electrons reads:

$$\mu_{e,\alpha\beta} = \frac{-1}{n_e \Omega} \sum_{n \in \text{CB}} \int \frac{d\mathbf{k}}{\Omega_{\text{BZ}}} v_{n\mathbf{k},\alpha} \partial_{E_\beta} f_{n\mathbf{k}}. \quad (1)$$

Here, $v_{n\mathbf{k},\alpha} = \hbar^{-1} \partial \varepsilon_{n\mathbf{k}} / \partial k_\alpha$ is the group velocity of the band state of energy $\varepsilon_{n\mathbf{k}}$, conduction band (CB) index n , and wave vector $\mathbf{k}$. n_e is the electron density, $\partial_{E_\beta} f_{n\mathbf{k}}$ is the perturbation to the Fermi-Dirac distribution induced by the applied electric field $\mathbf{E}$, Ω and Ω_{BZ} are the volumes of the crystalline unit cell and first Brillouin zone, respectively. Greek indices are Cartesian coordinates. The Berry

curvature contribution to the mobility arising from the anomalous velocity vanishes due to time-reversal symmetry, and does not appear in the BTE since we consider a homogeneous bulk system [22]. The perturbation to the equilibrium carrier distribution is obtained by solving the following self-consistent equation:

$$\partial_{E_\beta} f_{n\mathbf{k}} = e \frac{\partial f_{n\mathbf{k}}^0}{\partial \varepsilon_{n\mathbf{k}}} v_{n\mathbf{k},\beta} \tau_{n\mathbf{k}} + \frac{2\pi\tau_{n\mathbf{k}}}{\hbar} \sum_{m\nu\sigma} \int \frac{d\mathbf{q}}{\Omega_{\text{BZ}}} |g_{m\nu}(\mathbf{k}, \mathbf{q})|^2 [(1+\sigma)/2 - \sigma f_{n\mathbf{k}}^0 + n_{\mathbf{q}\nu}] \delta(\Delta \varepsilon_{\mathbf{k},\mathbf{q}}^{mn} + \sigma \hbar \omega_{\mathbf{q}\nu}) \partial_{E_\beta} f_{m\mathbf{k}+\mathbf{q}}, \quad (2)$$

where $\sigma \pm 1$ stands for phonon absorption or emission, $\Delta \varepsilon_{\mathbf{k},\mathbf{q}}^{mn} = \varepsilon_{n\mathbf{k}} - \varepsilon_{m\mathbf{k}+\mathbf{q}}$, and $f_{n\mathbf{k}}^0$ is the equilibrium distribution function. The matrix elements $g_{m\nu}(\mathbf{k}, \mathbf{q})$ are the probability amplitudes for scattering from an initial electronic state $n\mathbf{k}$ to a final state $m\mathbf{k} + \mathbf{q}$ via a phonon of branch index ν , crystal momentum $\mathbf{q}$, and frequency $\omega_{\mathbf{q}\nu}$. $n_{\mathbf{q}\nu}$ is the Bose-Einstein occupation of this mode. The quantity $\tau_{n\mathbf{k}}$ in Eq. (2) is the relaxation time, and is given by [23,24]

$$\frac{1}{\tau_{n\mathbf{k}}} = \frac{2\pi}{\hbar} \sum_{m\nu\sigma} \int \frac{d\mathbf{q}}{\Omega_{\text{BZ}}} |g_{m\nu}(\mathbf{k}, \mathbf{q})|^2 \times [(1+\sigma)/2 - \sigma f_{m\mathbf{k}+\mathbf{q}}^0 + n_{\mathbf{q}\nu}] \delta(\Delta \varepsilon_{\mathbf{k},\mathbf{q}}^{mn} - \sigma \hbar \omega_{\mathbf{q}\nu}). \quad (3)$$

In our calculations we first compute Eq. (3), then we solve Eq. (2) iteratively to obtain $\partial_{E_\beta} f_{n\mathbf{k}}$, and we use the result inside Eq. (1). Since most experiments report Hall-effect mobilities instead of drift mobilities, we also compute the Hall factor and scale our results accordingly, as discussed in the companion paper [25]. All calculations are based on density-functional theory including spin-orbit coupling (SOC) for the Kohn-Sham states, density-functional perturbation theory for phonons and electron-phonon matrix elements, and many-body perturbation theory for *GW* quasiparticle corrections, as implemented in the software packages QUANTUM ESPRESSO [26], YAMBO [27], WANNIER90 [28], and EPW [29,30]. Calculation details are provided in Ref. [25].

In Fig. 1 we show our calculated drift and Hall-effect mobilities for electrons and holes in intrinsic GaN as a function of temperature, and we compare our results with available experimental data. We find that the Hall mobility is about 15% higher than the drift mobility at room temperature, as expected [31]. Our predicted electron Hall mobility of 1030 cm²/V s and hole Hall mobility of 50 cm²/V s at 300 K are in good agreement with the measured values 1265 cm²/V s [18] and 31 cm²/V s [17], respectively.

In order to clarify the origin of the large difference between the electron and hole mobilities in GaN, we refer to Eqs. (1)–(3). In the simplest case of parabolic bands, in line with Drude's law, the mobility in Eq. (1) scales as

$e\tau/m^*$, with m^* and τ average effective mass and relaxation rate, respectively. As detailed in the companion paper [25], the conduction band bottom of GaN is singly degenerate, while at the valence band top we have a *lh* and a *hh*, which are split into doublets by SOC as we move from the Γ to M points of the Brillouin zone. The split-off hole will be discussed shortly. Our calculated effective masses are $m_{lh}^{\perp/\parallel} = 0.37/1.66m_e$, $m_{hh}^{\perp/\parallel} = 0.45/1.94m_e$, and $m_e^{\perp/\parallel} = 0.20/0.23m_e$, where $\perp$ and $\parallel$ denote the in-plane $\Gamma \rightarrow M$ or $\Gamma \rightarrow K$ directions and the out of plane $\Gamma \rightarrow A$ directions in the Brillouin zone. These values are in

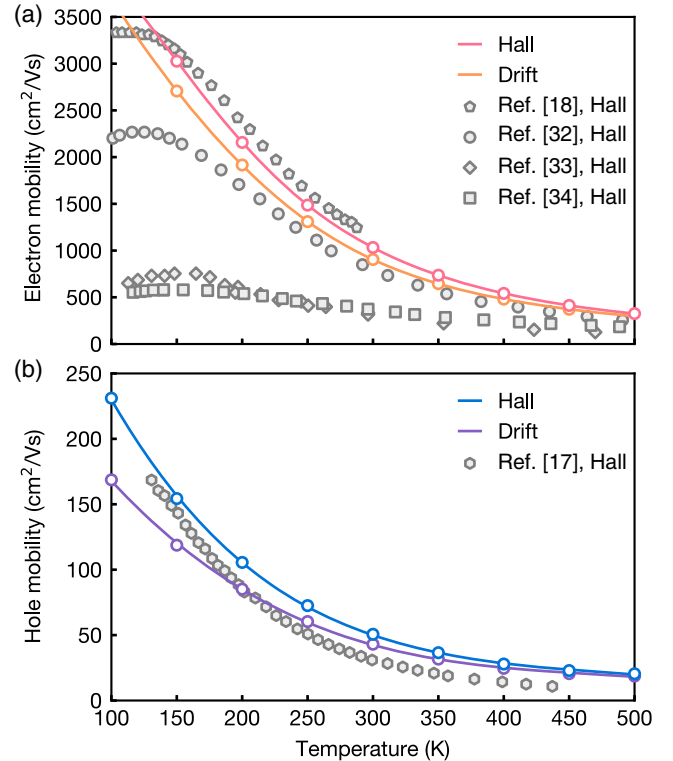


FIG. 1. Electron (a) and hole (b) mobilities of wurtzite GaN, calculated using the *ab initio* Boltzmann formalism, compared with the experimental data from Refs. [17,18,32–34]. We show both the drift mobilities computed via Eqs. (1)–(3) and the Hall mobilities obtained by applying the Hall factor taken from Ref. [25].

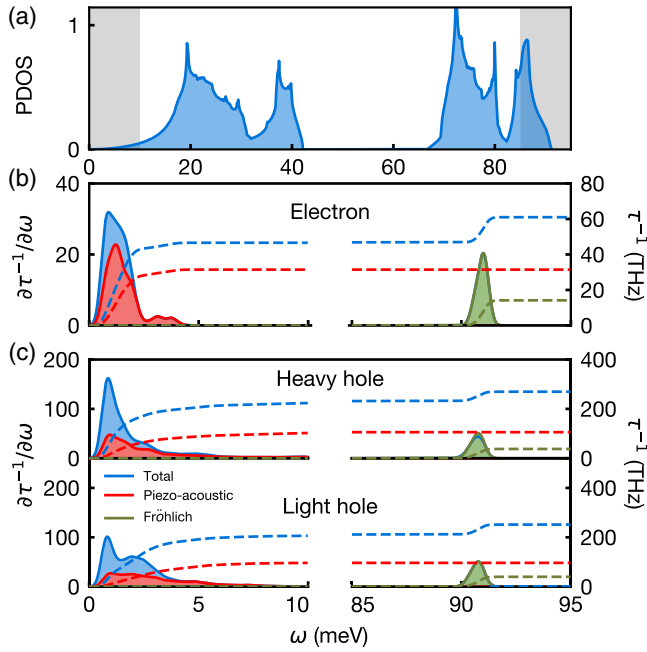


FIG. 2. Phonon density of states in GaN (a) and spectral decomposition of the electron (b) and hole (c) scattering rates as a function of phonon energy where the piezoacoustic (red) and polar Fröhlich (green) scattering rates have been highlighted. The rates are calculated as angular averages for carriers at an energy of $k_B T = 25$ meV away from the band edge (left vertical axis). The dashed lines represent the cumulative integral of each spectrum of $\partial\tau^{-1}/\partial\omega$, and add up to the carrier scattering rate τ^{-1} (right-hand vertical axis). The shadings in (a) indicate the energy ranges shown in (b) and (c).

reasonable agreement with experimental data ranging from $0.3m_e$ to $2.03m_e$ [35–39] for holes and in good agreement with $0.2m_e$ [40] for the electrons. The ratio between the conductivity effective masses (i.e., the harmonic averages) of electrons and holes is 2.4 for the hh and 2.9 for the lh case. These values are much smaller than the ratio between the calculated mobilities at room temperature ($1030/50 \approx 21$); therefore, the difference between electron and hole masses alone cannot fully account for the order-of-magnitude difference in carrier mobilities.

To identify the origin of the residual difference between electron and hole mobilities, in Fig. 2 we show the carrier relaxation rate $1/\tau$. Although every electronic state has its own lifetime τ_{nk} , for definiteness we report the values for carriers at an energy $k_B T = 25$ meV away from the band edges. We have shown previously that this is the most representative carrier energy [41]. Alongside the total relaxation rate, in this figure we also show the spectral decomposition of $1/\tau$ in terms of phonon energy and the phonon density of states for comparison. The main scattering channel is from long-wavelength acoustic phonons [peaks around a phonon energy of 2 meV in Figs. 2(b) and 2(c)], which account for 77% and 84% of the scattering rates for electrons and holes, respectively. The remaining

contribution is from the longitudinal-optical (LO) phonon near Γ , which is responsible for Fröhlich electron-phonon coupling. The scattering due to acoustic phonons can be further broken down into a piezoacoustic and an acoustic-deformation-potential (ADP) contribution [31]. The latter accounts for 48% and 61% of the total scattering for electrons and holes, respectively.

In the case of ADP scattering, the rates in Eq. (3) can be approximated by neglecting the phonon frequency in the Dirac delta function, and taking the matrix elements as a constant. This leads to a scattering rate that scales with the electronic density of states, and hence with the effective masses, as $1/\tau \approx (m^*)^{3/2}$. Our data approximately follow this trend. In fact, the electron lifetimes in Fig. 2 are in the range of 17 fs, while the hole lifetimes are much shorter, around 4 fs. Their ratio $17/4 \approx 4$ is of the same magnitude as the corresponding ratio between the conductivity effective masses, $(m_{lh}^*)^{3/2}/(m_e^*)^{3/2} = 3.7$ and $(m_{hh}^*)^{3/2}/(m_e^*)^{3/2} = 4.9$. This finding indicates that the high density of states associated with the lh and hh bands plays a central role in reducing hole lifetimes and hence suppressing their mobility. Other effects also contribute to reducing hole mobilities, albeit to a lesser extent: for example, the presence of multiple scattering channels for the holes (two spin-split sets of bands), the strong non-parabolicity of the hh band [38,42–44], and the longitudinal-optical phonons. All these effects are fully accounted for in our *ab initio* BTE formalism. We note that this analysis holds for electron or hole states ~ 25 meV from the band edges, and should be reevaluated for heavily degenerate 2D electron or hole gases.

How can one improve the hole mobility in GaN? Since the low mobilities stem primarily from the presence of two adjacent bands with heavy masses, one possibility is to check whether we can remove at least one of these bands via strain engineering, or alternatively bring the light sh hole nearer to the valence band top. It turns out that the lh and hh bands are separated by the spin-orbit splitting Δ_{so} , and this splitting is relatively insensitive to strain, as discussed in our companion paper [25]. However, the separation between the $lh-hh$ and the sh bands is controlled by the crystal-field splitting Δ_{cf} . This quantity is known to be sensitive to the internal parameter u of the wurtzite structure, or equivalently to a change of the c/a ratio [42,45]. In Fig. 3(d) we show that Δ_{cf} can indeed be altered by biaxial or uniaxial strain. Most importantly, a lattice distortion that reduces the c/a ratio or increases the u parameter can reverse the sign of the crystal-field splitting; this is the case for biaxial tensile strain (along $[2\bar{1}\bar{1}0]$ and $[\bar{1}2\bar{1}0]$) and for uniaxial compressive strain (along $[0001]$). Under these conditions we can have the sh band being lifted above the lh and hh bands, as shown in Fig. 3(a). This effect alters the ordering of the valence band top, as well as the character of the wave functions; see Fig. 3(c). In particular, the hole wave functions go from

$N-p_{x,y}$ states to $N-p_z$ states. If we consider instead a biaxial compressive strain or uniaxial tensile strain, the c/a ratio increases and Δ_{cf} maintains the same sign but increases in magnitude. In this case, the band ordering remains unchanged from the situation in bulk unstrained GaN. The conductivity effective mass of the sh band is $m_{sh}^* = 0.45m_e$ at the zone center, but away from Γ it quickly decreases to $m_{sh}^* = 0.22m_e$ due to strong nonparabolicity. Since this value is much smaller than the masses of the lh and hh bands, we hypothesize that the hole mobility of GaN will improve upon reversal of the sign of Δ_{cf} .

To test our hypothesis we repeat all transport calculations for strained GaN. Figure 3(f) shows the hole mobility of GaN computed for biaxial tensile strains of 1% and of 2%. Similar results can be found for the case of uniaxial compressive strain [25]. The electron mobility is much less affected by strain. The results confirm indeed our expectation that, as soon as we change the sign of Δ_{cf} , we have an enhancement in the hole mobility. In particular, the comparison between Figs. 3(d) and 3(e) shows that the hole mobility nicely tracks the quantity $\max(-\Delta_{cf}, 0)$, thus further confirming our point.

As shown in Fig. 3(f) and in the companion paper [25], we predict a significant increase of the hole mobility at room temperature, up to $\sim 120 \text{ cm}^2/\text{Vs}$ under 2% biaxial dilatation or 2% uniaxial compression. This value represents a 230% increase in the hole mobility with respect to unstrained GaN. We emphasize that our results are not sensitive to the details of the calculations, since they are

rooted in a change of band character of the valence band top under an elastic deformation. This is confirmed by explicit calculations of Δ_{cf} using different functionals.

How realistic is our proposal? We computed the GaN phase diagram to check that the wurzite structure remains the lowest-enthalpy phase under strain [25]. Engineering biaxial strain of up to 4% is feasible nowadays by growing GaN on epitaxial substrates such as AlN or 6H-SiC [46,47]. Furthermore, the most common substrate for growing GaN is 6H-SiC, and the lattice mismatch in this case is 3.5% [46]. The reason why high hole mobilities have not yet been observed for GaN grown on these substrates may be that GaN films are so thick that the crystal lattice accommodates the strain via misfit dislocations [48], which further decrease the mobility. Therefore, to realize high-hole-mobility GaN one should devise strategies for preventing dislocation nucleation.

One possibility would be to grow GaN films thinner than the Fischer critical thickness for misfit dislocations [49,50], which we computed to be 7 nm at 2% strain (see companion paper [25]) and should also mitigate cracking under stress [51]. For GaN on AlN it was recently shown that the critical thickness ranges between 3 and 30 monolayers depending on the growth temperature [52]. Such layer thicknesses have recently become possible [53,54]; therefore, our present proposal should be feasible by carefully controlling the growth conditions. The switching of the valence band ordering could be detected optically by measuring the polarization of optical emission from such

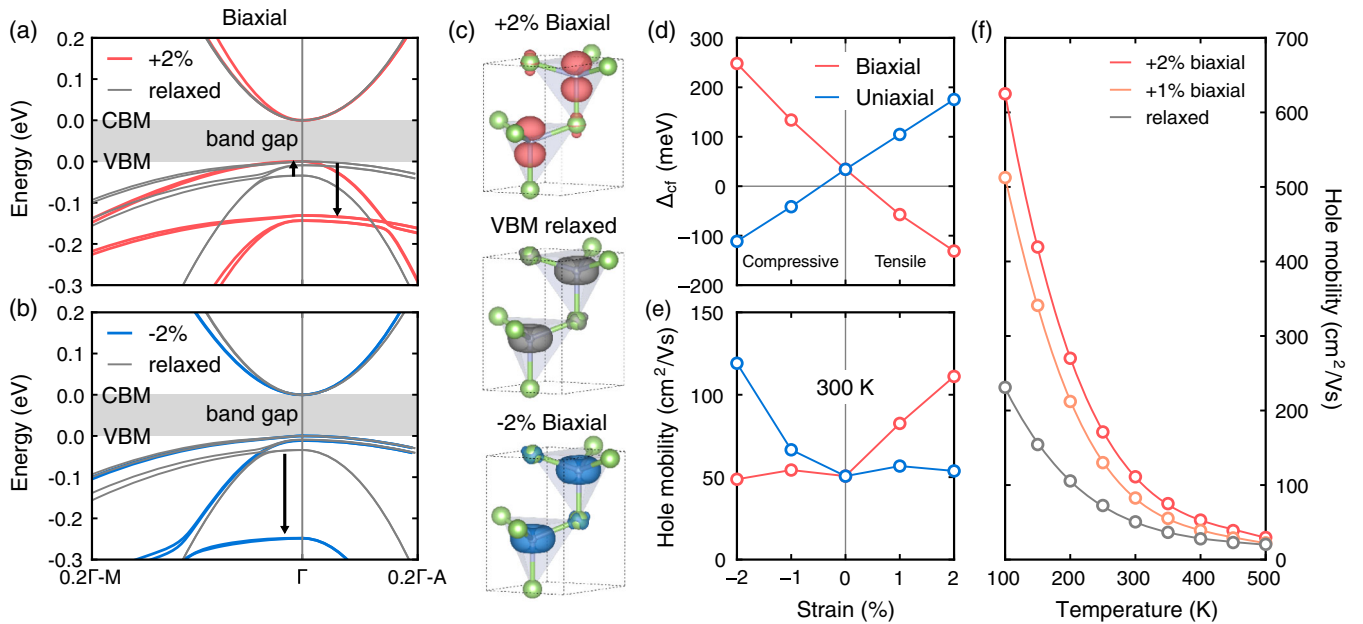


FIG. 3. Crystal-field engineering of band structure and mobility in GaN. (a),(b) Change in the GW quasiparticle band structure of GaN upon biaxial dilation and compression, respectively. The energy levels have been aligned to the conduction band minimum (CBM) and valence band maximum (VBM). (c) Electron wave function at the VBM at Γ for the undistorted wurzite GaN structure, as well as for 2% biaxial dilation and 2% biaxial compression, respectively. (d) Crystal-field splitting Δ_{cf} versus strain and (e) corresponding hole Hall mobility at 300 K. (f) Predicted temperature-dependent hole mobility in wurzite GaN as a function of biaxial strain.

layers [55]. Furthermore, in previous work the GaN samples were thicker than the Matthews-Blakeslee critical thickness [49]; therefore, in those cases the hole mobility enhancement is expected to be suppressed by dislocation scattering.

Another intriguing possibility for increasing the hole mobility of GaN could be to tune the crystal-field splitting via the internal parameter u . Since this parameter is controlled by the A_1 transverse-optical phonon at Γ , it should be possible to control the hole mobility via light, by coherently exciting optical phonons with femtosecond infrared pulses. Light-induced control of transport coefficients has already been demonstrated for NdNiO_3 [56], and recent developments in the parametric amplification of optical phonons [57] offer many new opportunities in this direction.

In summary, we have shown that the origin of the low hole mobilities in GaN lies in a combination of heavy carrier effective masses and high density of final electronic states available for scattering via low-energy acoustic phonons. We find that this bottleneck can be circumvented by modifying the ordering of the valence band top, in such a way as to have the split-off holes above the light holes and heavy holes. We propose to realize such band inversion by reversing the sign of the crystal-field splitting via strain engineering or via optical phonon pumping. We hope that this work will stimulate experimental research in high-hole-mobility GaN and will accelerate progress towards GaN-based CMOS technology.

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